



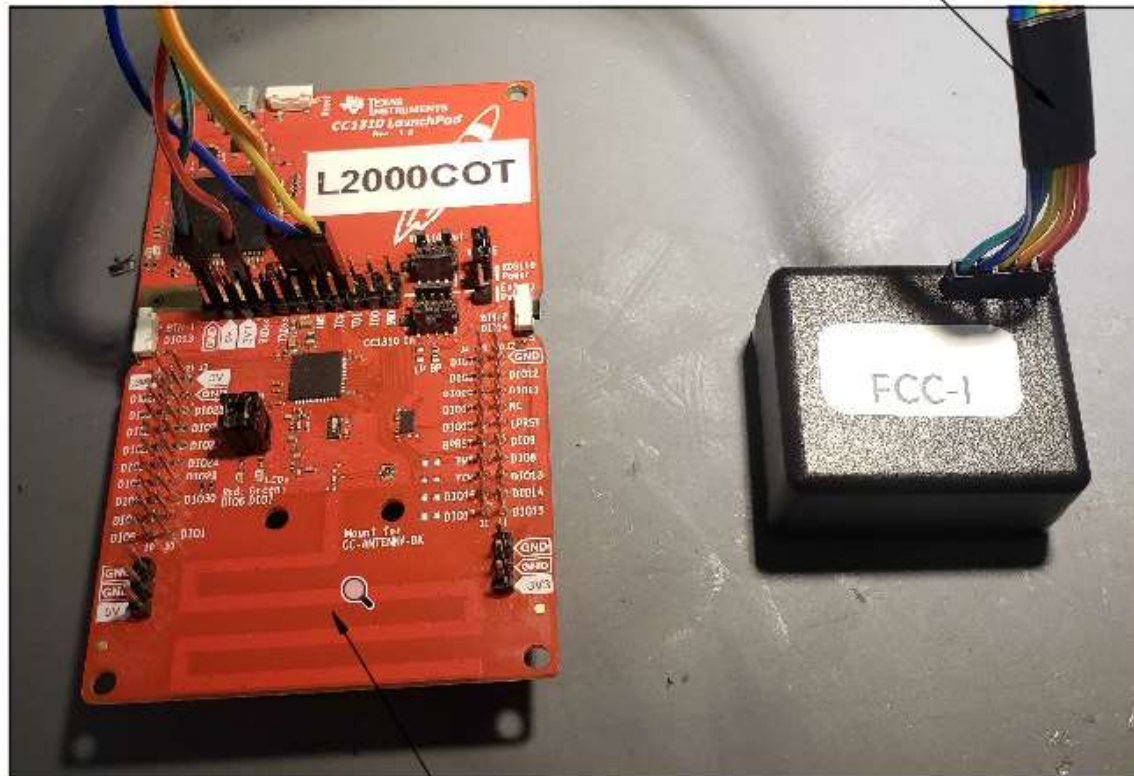
DUT used for radiated emissions testing



Access to
U.FL jack

DUT used for conducted emissions testing

Power and JTAG connection



Texas Instruments Launchpad
development kit will be used to
control the DUT during testing

Anticipated test setup